## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant:

M. REINSTÄDTLER, et al.

Serial No:

To be assigned

Filed:

February 16, 2005

Title:

METHOD FOR DETERMINING TRIBOLOGICAL PROPERTIES

OF A SAMPLE SURFACE USING AN ATOMIC FORCE SCANNING MICROSCOPE AND AN ATOMIC FORCE

SCANNING MICROSCOPE THEREFORE

## **PRELIMINARY AMENDMENT**

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

February 16, 2005

Sir:

Please amend the above-identified application as listed below and as set forth on the following pages:

Amendments to the Specification

Amendments to the Claims

Remarks are included following the amendments